





Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10615347	LIUHTO ET AL.
	Examiner Nguyen, Tammy T	Art Unit 2144

Notes	Date	Examiner
UPDATED SEARCH EAST	5/25/06	TTN
US-PG PUB		TTN
EPO		TTN
JPO		TTN
IEEE		TTN
ACM		TTN
CONSULTED VAUGHN	10/20/06	TTN
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Interference Searched 	Application/Control No. 10615347	Applicant(s)/Patent Under Reexamination LIUHTO ET AL.
	Examiner Nguyen, Tammy T	Art Unit 2144

Class	SubClass	Date	Examiner
709	236	5/25/06	TTN
709	232		TTN
709	249		TTN
370	252		TTN
370	213		TTN
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<p>Searched</p> 	<p>Application/Control No.</p> <p>10615347</p>	<p>Applicant(s)/Patent Under Reexamination</p> <p>LIUHTO ET AL.</p>
	<p>Examiner</p> <p>Nguyen, Tammy T</p>	<p>Art Unit</p> <p>2144</p>

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709	236	5/25/06	TTN
709	232		TTN
709	249		TTN
370	252		TTN
370	213		TTN
714	749		TTN

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